

NHD-7.0-800480EF-20 Controller Board

TFT Controller Evaluation Board

NHD-	Newhaven Display
7.0-	7.0" Diagonal
800480-	800 x 480 Pixels
EF-	Model
20-	20-pin FFC Interface (8-bit Parallel Data) SSD1963 Controller

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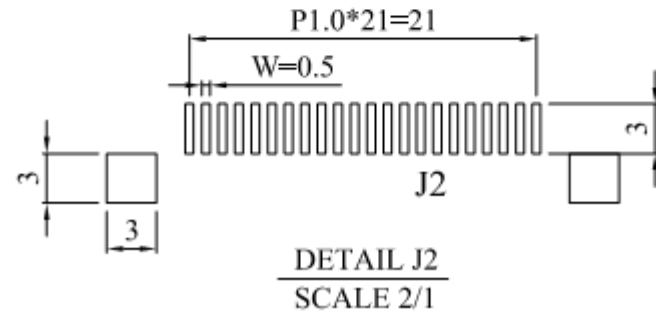
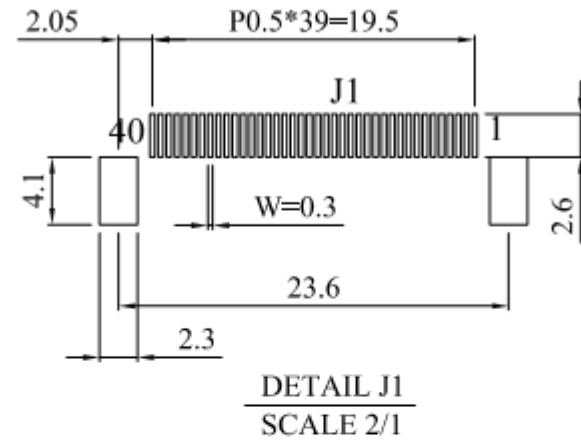
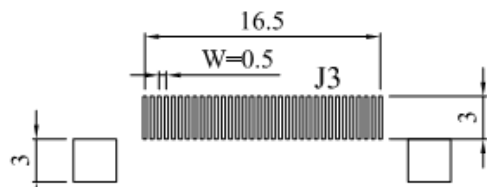
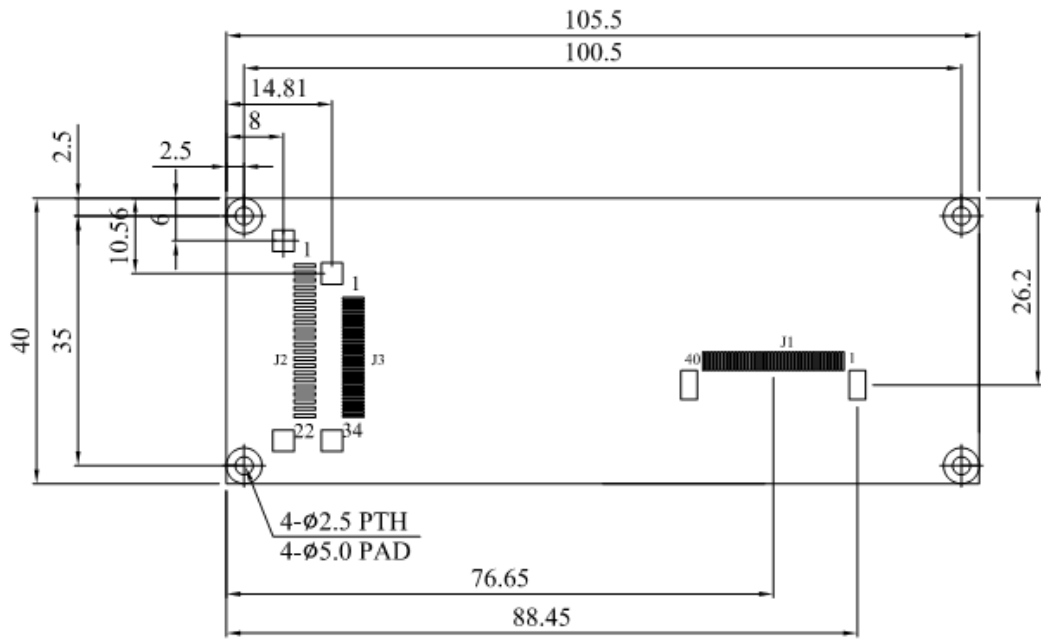
Document Revision History

Revision	Date	Description	Changed by
0	12/14/2013	Initial Release	AK

Functions and Features

- To use for testing, evaluating, or in final production with NHD-7.0-800480EF-A displays.

Mechanical Drawing



Pin Description: J1 (SSD1963 output to display panel)

Pin No.	Symbol	Connection	Function Description
1	LED-K	Power Supply	Backlight Cathode
2	LED-A	Power Supply	Backlight Anode (60mA @ 16V)
3	GND	Power Supply	Ground
4	VDD	Power Supply	Power Supply (+3.3V)
5-12	[R0-R7]	MPU	Red Data Signals
13-20	[G0-G7]	MPU	Green Data Signals
21-28	[B0-B7]	MPU	Blue Data Signals
29	GND	Power Supply	Ground
30	CLKIN	MPU	Clock for input data
31	DISP	MPU	Display on/off DISP=1:Display on
32	HSD	MPU	Line synchronization signal
33	VSD	MPU	Frame synchronization signal
34	DEN	MPU	Data Enable signal
35	NC	-	No Connect
36	GND	Power Supply	Ground
37	NC	-	No Connect
38	NC	-	No Connect
39	NC	-	No Connect
40	NC	-	No Connect

Pin Description: J2 (SSD1963 input from user's MPU)

Pin No.	Symbol	External Connection	Function Description
1	GND	Power Supply	Ground
2	VDD	Power Supply	Power supply for LCD and logic (3.3V)
3	B/L Enable	Power Supply	Backlight Enable
4	D/C	MPU	Data/Command select. D/C=0: Command, D/C=1: Data
5	/WR	MPU	Active LOW Write signal
6	/RD	MPU	Active LOW Read signal
7-14	DB0-DB7	MPU	8-bit bidirectional data bus
15	/CS	MPU	Active LOW Chip Select signal
16	/RESET	MPU	Active LOW Reset signal
17	NC	-	No Connect
18	NC	-	No Connect
19	DISP	MPU	Display On signal
20	NC	-	No Connect

Note: J2 has a 20-pin FFC connector installed; pins 21, 22 are not connected.

Electrical Characteristics

Item	Symbol	Condition	Min.	Typ.	Max.	Unit
Operating Temperature Range	Top	Absolute Max	-20	-	+70	°C
Storage Temperature Range	Tst	Absolute Max	-30	-	+80	°C
Supply Voltage	VDD		3.0	3.3	3.6	V
Input High Voltage	VIH		0.8*VDD	-	VDD	V
Input Low Voltage	VIL		0	-	0.2*VDD	V
Supply Current	IDD		-	285	-	mA

Controller Information

Built-in SSD1963 controller.

Please download specification at http://www.newhavendisplay.com/app_notes/SSD1963.pdf

Table of Commands

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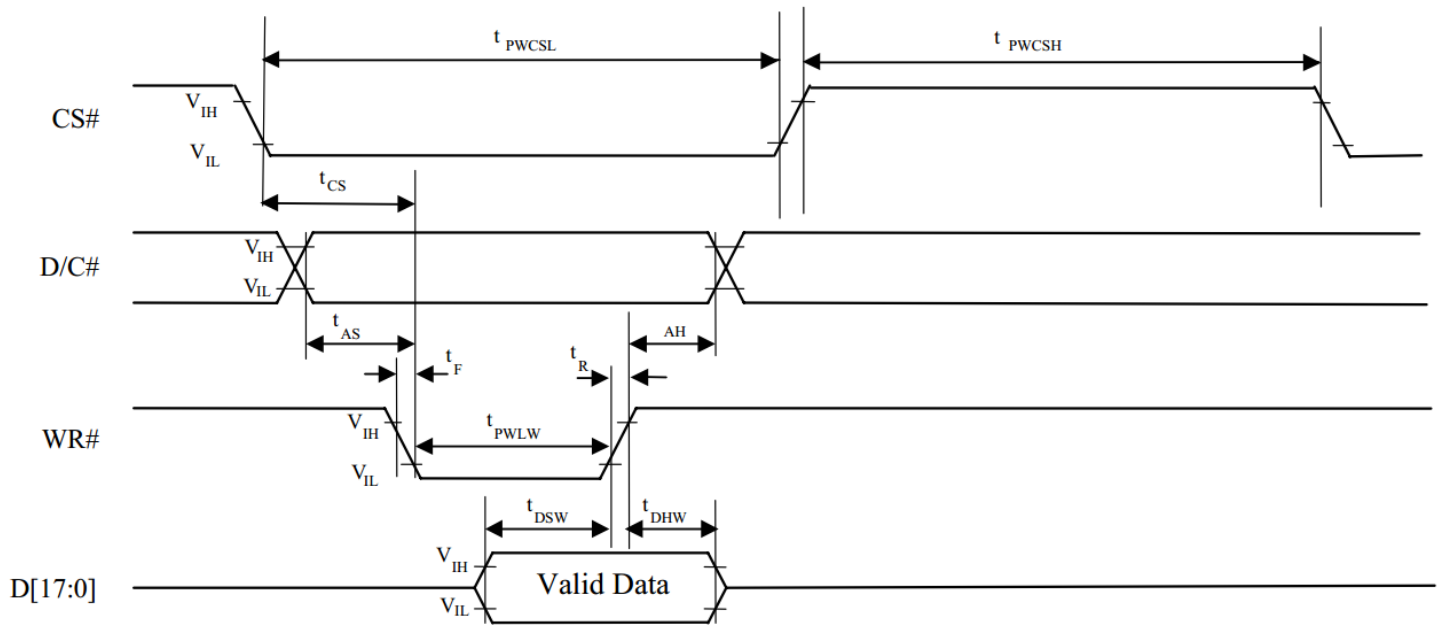
Timing Characteristics

Parallel 8080-series Interface Timing Characteristics

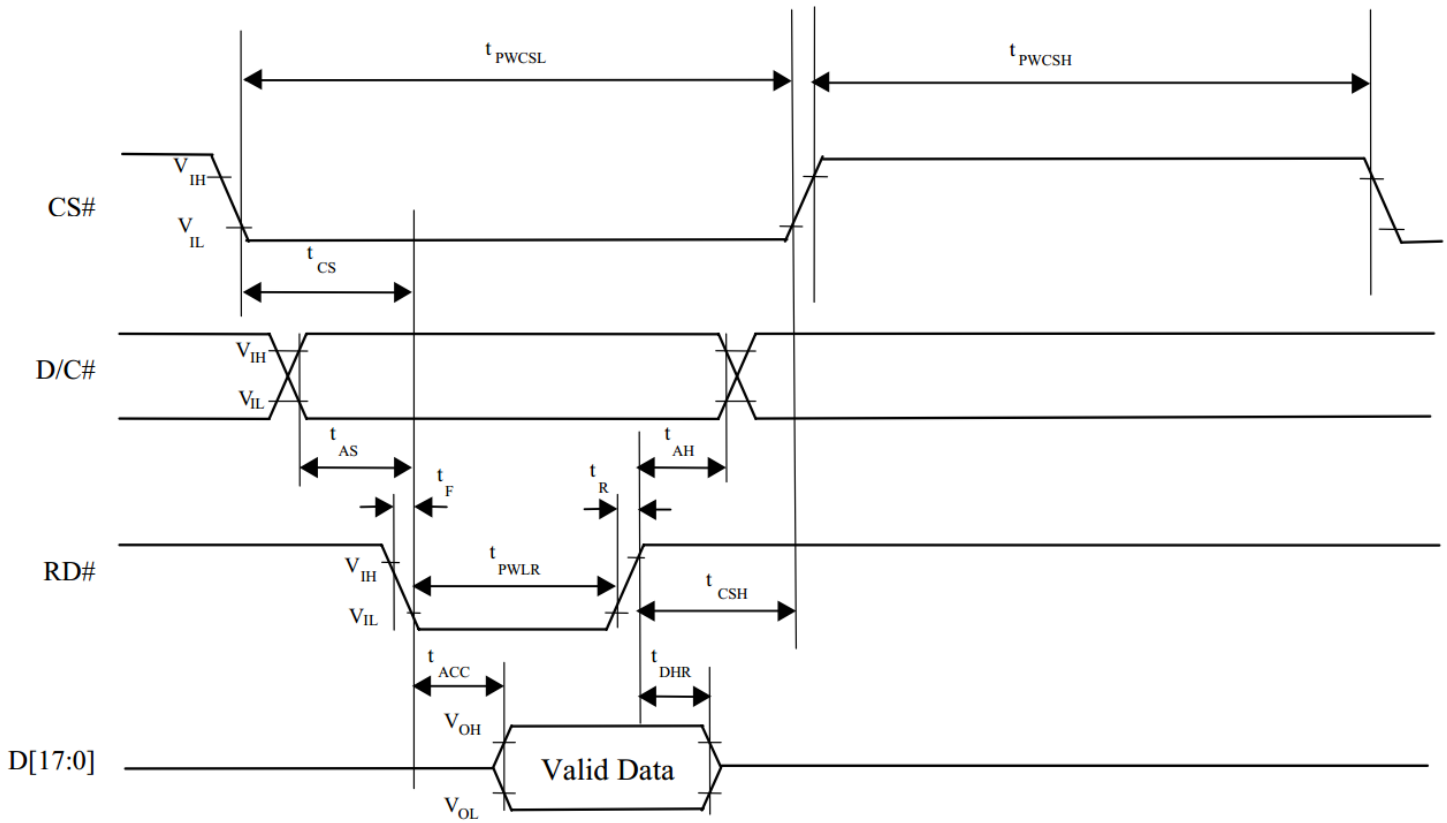
Symbol	Parameter	Min	Typ	Max	Unit
f_{MCLK}	System Clock Frequency*	1	-	110	MHz
t_{MCLK}	System Clock Period*	$1/f_{MCLK}$	-	-	ns
t_{PWCSL}	Control Pulse High Width	Write Read	13 30	$1.5 * t_{MCLK}$ $3.5 * t_{MCLK}$	- ns
t_{PWCSH}	Control Pulse Low Width	Write (next write cycle) Write (next read cycle) Read	13 80 80	$1.5 * t_{MCLK}$ $9 * t_{MCLK}$ $9 * t_{MCLK}$	- ns
t_{AS}	Address Setup Time	1	-	-	ns
t_{AH}	Address Hold Time	2	-	-	ns
t_{DSW}	Write Data Setup Time	4	-	-	ns
t_{DHW}	Write Data Hold Time	1	-	-	ns
t_{PWLW}	Write Low Time	12	-	-	ns
t_{DHR}	Read Data Hold Time	1	-	-	ns
t_{ACC}	Access Time	32	-	-	ns
t_{PWLR}	Read Low Time	36	-	-	ns
t_R	Rise Time	-	-	0.5	ns
t_F	Fall Time	-	-	0.5	ns
t_{CS}	Chip select setup time	2	-	-	ns
t_{CSH}	Chip select hold time to read signal	3	-	-	ns

* System Clock denotes external input clock (PLL-bypass) or internal generated clock (PLL-enabled)

Write Cycle



Read Cycle



Quality Information

Test Item	Content of Test	Test Condition	Note
High Temperature storage	Endurance test applying the high storage temperature for a long time.	+80°C , 200hrs	2
Low Temperature storage	Endurance test applying the low storage temperature for a long time.	-30°C , 200hrs	1,2
High Temperature Operation	Endurance test applying the electric stress (voltage & current) and the high thermal stress for a long time.	+70°C 200hrs	2
Low Temperature Operation	Endurance test applying the electric stress (voltage & current) and the low thermal stress for a long time.	-20°C , 200hrs	1,2
High Temperature / Humidity Operation	Endurance test applying the electric stress (voltage & current) and the high thermal with high humidity stress for a long time.	+60°C , 90% RH , 96hrs	1,2
Thermal Shock resistance	Endurance test applying the electric stress (voltage & current) during a cycle of low and high thermal stress.	-20°C,30min -> 25°C,5min -> 70°C,30min = 1 cycle 10 cycles	
Vibration test	Endurance test applying vibration to simulate transportation and use.	10-55Hz , 15mm amplitude. 60 sec in each of 3 directions X,Y,Z For 15 minutes	3
Static electricity test	Endurance test applying electric static discharge.	VS=800V, RS=1.5kΩ, CS=100pF One time	

Note 1: No condensation to be observed.

Note 2: Conducted after 4 hours of storage at 25°C, 0%RH.

Note 3: Test performed on product itself, not inside a container.

Precautions for using LCDs/LCMs

See Precautions at www.newhavendisplay.com/specs/precautions.pdf

Warranty Information and Terms & Conditions

http://www.newhavendisplay.com/index.php?main_page=terms